



ISO 25178-602

**Geometrical product specifications
(GPS) — Surface texture: Areal —**

Part 602:
**Design and characteristics of non-
contact (confocal chromatic probe)
instruments**

*Spécification géométrique des produits (GPS) — État de surface:
Surfacique —*

*Partie 602: Conception et caractéristiques des instruments sans
contact (à capteur confocal chromatique)*

**Second edition
2025-02**

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Published in Switzerland

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This document was prepared by Technical Committee ISO/TC 213, *Dimensional and geometrical product specifications and verification*, in collaboration with the European Committee for Standardization (CEN) Technical Committee CEN/TC 290, *Dimensional and geometrical product specification and verification*, in accordance with the Agreement on technical cooperation between ISO and CEN (Vienna Agreement).

This second edition cancels and replaces the first edition (ISO 25178-602:2010), which has been technically revised.

The main changes are as follows:

- removal of the terms and the definitions now specified in ISO 25178-600;
- revision of all terms and definitions for clarity and consistency with other ISO standards;
- addition of [Clause 4](#) for instrument requirements, which summarizes the normative features and characteristics of instruments;
- addition of [Clause 5](#) on metrological characteristics;
- addition of [Clause 6](#) on design features, which clarifies the types of instruments relevant to this document;
- addition of an information flow concept diagram in [Clause 4](#);
- revision of [Annex A](#) describing the principles of instruments addressed by this document.

A list of all parts in the ISO 25178 series can be found on the ISO website.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

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This document is a geometrical product specification (GPS) standard and is to be regarded as a general GPS standard (see ISO 14638). It influences chain link F of the chains of standards on profile and areal surface texture.

The ISO GPS matrix model given in ISO 14638 gives an overview of the ISO GPS system of which this document is a part. The fundamental rules of ISO GPS given in ISO 8015 apply to this document and the default decision rules given in ISO 14253-1 apply to the specifications made in accordance with this document, unless otherwise indicated.

For more detailed information on the relation of this document to other standards and the GPS matrix model, see [Annex C](#).

The principle of confocal chromatic probe can be implemented in various set-ups. The configuration described in this document comprises three basic elements: an optoelectronic controller, a linking fibre optic cable and a chromatic objective (sometimes called “optical pen”).

Several techniques are possible to create the axial chromatic aberration or to extract the height information from the reflected light. In addition to implementations as point sensors, chromatic aberration can be integrated into line sensors and field sensors. [Annex A](#) describes confocal chromatic imaging and its implementation into distance measurement probes in detail.

This type of instrument is mainly designed for areal measurements, but it is also able to perform profiling measurements.

This document describes the design and the metrological characteristics of an optical profiler using a confocal chromatic probe based on axial chromatic aberration of white light, designed for the measurement of areal surface texture.

For more detailed information on the confocal chromatic probe instrument technique, see [Annex A](#). Reading this annex before the main body can lead to a better understanding of this document.